DATA SHEET 74LVT16244B 3.3 V LVT 16-bit buffer/driver (3-State)

INTEGRATED CIRCUITS

Product data Supersedes data of 1998 Oct 07 2002 Oct 31







74LVT16244B

FEATURES

- 16-bit bus interface
- 3-State buffers
- Output capability: +64 mA / -32 mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5 V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up 3-State
- No bus current loading when output is tied to 5 V bus
- Latch-up protection exceeds 500 mA per JEDEC Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model

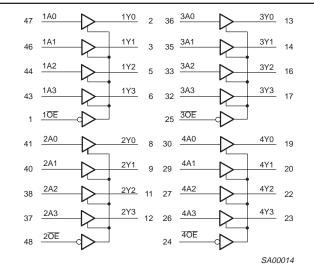
QUICK REFERENCE DATA

CONDITIONS SYMBOL PARAMETER TYPICAL UNIT T_{amb} = 25 °C $C_{L} = 50 \, pF;$ t_{PLH} Propagation delay 1.8 ns $V_{CC} = 3.3 V$ nAx to nYx t_{PHL} CIN Input capacitance nOE $V_{I} = 0 V \text{ or } 3.0 V$ 3 pF 9 Outputs disabled; Output capacitance $V_{O} = 0 V \text{ or } 3.0 V$ pF COUT Outputs disabled; $V_{CC} = 3.6 V$ 70 I_{CCZ} Total supply current μΑ

ORDERING INFORMATION

TYPE NUMBER	PACKAGE	TEMPERATURE RANGE	DWG NUMBER
74LVT16244BDL	48-Pin Plastic SSOP Type III	–40 °C to +85 °C	SOT370-1
74LVT16244BDGG	48-Pin Plastic TSSOP Type II	–40 °C to +85 °C	SOT362-1
74LVT16244BEV	56VFBGA Ball Grid Array	–40 °C to +85 °C	SOT702-1

LOGIC SYMBOL



NOTE:

Pin numbers are shown for SSOP and TSSOP packages only.

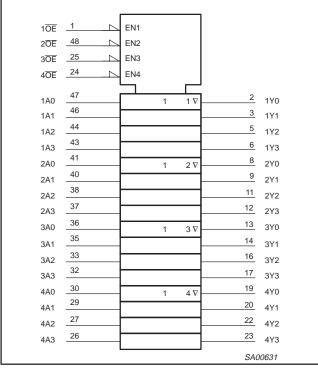
DESCRIPTION

The 74LVT16244B is a high-performance BiCMOS product designed for V_{CC} operation at 3.3 V.

This device is a 16-bit buffer and line driver featuring non-inverting 3-State bus outputs. The device can be used as four 4-bit buffers, two 8-bit buffers, or one 16-bit buffer.

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LOGIC SYMBOL (IEEE/IEC)



NOTE:

Pin numbers are shown for SSOP and TSSOP packages only.

FUNCTION TABLE

INP	OUTPUTS	
nOE	nAx	nYx
L	L	L
L	н	н
н	Х	Z

H = High voltage level

L = Low voltage level

X = Don't care

Z = High Impedance "off" state

PIN CONFIGURATION

48-pin SSOP and TSSOP

		1
1 0E	1	48 2 0E
1Y0	2	47 1A0
1Y1	3	46 1A1
GND	4	45 GND
1Y2	5	44 1A2
1Y3	6	43 1A3
VCC	7	42 V _{CC}
2Y0	8	41 2A0
2Y1	9	40 2A1
GND	10	39 GND
2Y2	11	38 2A2
2Y3	12	37 2A3
3Y0	13	36 3A0
3Y1	14	35 3A1
GND	15	34 GND
3Y2	16	33 3A2
3Y4	17	32 3A3
VCC	18	31 V _{CC}
4Y0	19	30 4A0
4Y1	20	29 4A1
GND	21	28 GND
4Y2	22	27 4A2
4Y3	23	26 4A3
4OE	24	25 3 0E
	L	1
		SA00013

PIN DESCRIPTION

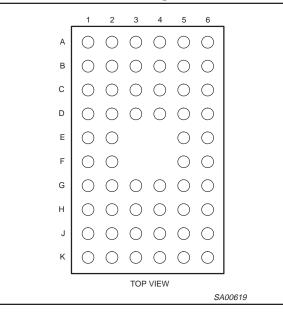
48-pin SSOP and TSSOP

PIN NUMBER	SYMBOL	NAME AND FUNCTION
47, 46, 44, 43 41, 40, 38, 37 36, 35, 33, 32 30, 29, 27, 26	1A0 - 1A3, 2A0 - 2A3, 3A0 - 3A3, 4A0 - 4A3	Data inputs
2, 3, 5, 6 8, 9, 11, 12 13, 14, 16, 17 19, 20, 22, 23	1Y0 - 1Y3, 2Y0 - 2Y3, 3Y0 - 3Y3, 4Y0 - 4Y3	Data outputs
1, 48 25, 24	1 <u>0E</u> , 2 <u>0E,</u> 3 <u>0E</u> , 4 <u>0E</u>	Output enables
4, 10, 15, 21 28, 34, 39, 45	GND	Ground (0V)
7, 18, 31, 42	V _{CC}	Positive supply voltage

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PIN CONFIGURATION

56-ball VFBGA terminal assignments



PIN DESCRIPTION

	1	2	3	4	5	6
А	1 0E	NC	NC	NC	NC	2 0E
В	1Y1	1Y0	GND	GND	1A0	1A1
С	1Y3	1Y2	V _{CC}	V _{CC}	1A2	1A3
D	2Y1	2Y0	GND	GND	2A0	2A1
E	2Y3	2Y2			2A2	2A3
F	3Y0	3Y1			3A1	3A0
G	3Y2	3Y3	GND	GND	3A3	3A2
н	4Y0	4Y1	V _{CC}	V _{CC}	4A1	4A0
J	4Y2	4Y3	GND	GND	4A3	4A2
к	4 0E	NC	NC	NC	NC	3 0E

56-ball VFBGA terminal assignments

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ABSOLUTE MAXIMUM RATINGS^{1, 2}

SYMBOL	PARAMETER	PARAMETER CONDITIONS		UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V ₁ < 0	-50	mA
VI	DC input voltage ³		-0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in OFF or HIGH state	-0.5 to +7.0	V
		Output in LOW state		mA
IOUT	DC output current	Output in HIGH state	-64	mA
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C. 3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	LIM	UNIT	
STMBOL	PARAIVETER	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.7	3.6	V
VI	Input voltage	0	5.5	V
V _{IH}	HIGH-level input voltage	2.0		V
V _{IL}	Input voltage		0.8	V
I _{OH}	HIGH-level output current		-32	mA
	LOW-level output current		32	mA
IOL	LOW-level output current; current duty cycle \leq 50%; f \geq 1 kHz		64	ША
$\Delta t/\Delta v$	Input transition rise or fall rate; Outputs enabled		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	°C

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					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS		Temp = -	-40 °C to	+85 °C	UNIT
						MAX	
V _{IK}	Input clamp voltage	V _{CC} = 2.7 V; I _{IK} = -18 mA		-0.85	-1.2	V	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V; } I_{OH} = -100 \mu\text{A}$		V _{CC} -0.2	V _{CC}		
V _{OH}	High-level output voltage	V _{CC} = 2.7 V; I _{OH} = -8 mA		2.4	2.5		V
		V _{CC} = 3.0 V; I _{OH} = -32 mA		2.0	2.3		
		V _{CC} = 2.7 V; I _{OL} = 100 μA			0.07	0.2	
		V _{CC} = 2.7 V; I _{OL} = 24 mA			0.3	0.5	
V _{OL}	Low-level output voltage	V _{CC} = 3.0 V; I _{OL} = 16 mA			0.25	0.4	V
		V _{CC} = 3.0 V; I _{OL} = 32 mA			0.3	0.5	
		V _{CC} = 3.0 V; I _{OL} = 64 mA		0.4	0.55		
	Input leakage current	$V_{CC} = 3.6 \text{ V}; \text{ V}_{I} = V_{CC} \text{ or GND}$	Control pins		0.1	±1.0	
		V _{CC} = 0 V or 3.6 V; V _I = 5.5 V		0.4	10		
łı		$V_{CC} = 3.6 \text{ V}; \text{ V}_{I} = V_{CC}$	Datania 4		0.1	1	μA
		$V_{CC} = 3.6 \text{ V}; \text{ V}_{I} = 0$	Data pins ⁴		-0.4	-5	
I _{OFF}	Output off current	$V_{CC} = 0$ V; V_{I} or $V_{O} = 0$ V to 4.5 V	•		0.1	±100	μΑ
		$V_{CC} = 3 \text{ V}; \text{ V}_{I} = 0.8 \text{ V}$		75	135		1
I _{HOLD}	Bus Hold current A inputs ⁶	$V_{CC} = 3 \text{ V}; \text{ V}_{I} = 2.0 \text{ V}$	-75	-135		μA	
		$V_{CC} = 0 V$ to 3.6 V; $V_{CC} = 3.6 V$	±500				
I_{EX}	Current into an output in the HIGH state when $V_O > V_{CC}$	$V_{O} = 5.5 \text{ V}; V_{CC} = 3.0 \text{ V}$			50	125	μA
I _{PU/PD}	Power-up/down 3-State output current ³	$V_{CC} \leq$ 1.2 V; V_{O} = 0.5 V to $V_{CC};$ V_{I} = GN OE/OE = Don't care	D or V _{CC}		1	±100	μA
I _{OZH}	3-State output HIGH current	$V_{CC} = 3.6 \text{ V}; V_{O} = 3.0 \text{ V}; V_{I} = V_{IL} \text{ or } V_{IH}$			0.5	5	μΑ
I _{OZL}	3-State output LOW current	$V_{CC} = 3.6 \text{ V}; V_{O} = 0.5 \text{ V}; V_{I} = V_{IL} \text{ or } V_{IH}$		0.5	-5	μΑ	
I _{CCH}		V_{CC} = 3.6 V; Outputs HIGH, V _I = GND or		0.07	0.12		
I _{CCL}	Quiescent supply current	$V_{CC} = 3.6$ V; Outputs LOW, $V_I = GND$ or V_{CC} , $I_O = 0$		4.0	4.0	6.0	mA
I _{CCZ}	1	V_{CC} = 3.6 V; Outputs Disabled; V_{I} = GNE	0 ⁵ 0.0	0.07	0.12		
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 3 V to 3.6 V; One input at V_{CC} -0.6 Other inputs at V_{CC} or GND	3 V,		0.1	0.2	mA

DC ELECTRICAL CHARACTERISTICS

NOTES:

NOTES:

 All typical values are at V_{CC} = 3.3 V and T_{amb} = 25 °C.
 This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND.
 This parameter is valid for any V_{CC} between 0 V and 1.2 V with a transition time of up to 10 msec. From V_{CC} = 1.2 V to V_{CC} = 3.3 V ± 0.3 V a transition time of 100 µsec is permitted. This parameter is valid for T_{amb} = 25 °C only.
 Unused pins at V_{CC} or GND.
 I_{CCZ} is measured with outputs pulled to V_{CC} or GND.

 This is the bus-hold overdrive current required to force the input to the opposite logic state.

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AC CHARACTERISTICS

GND = 0 V; $t_R = t_F$ = 2.5 ns; C_L = 50 pF; R_L = 500 Ω ; T_{amb} = -40 °C to +85 °C.

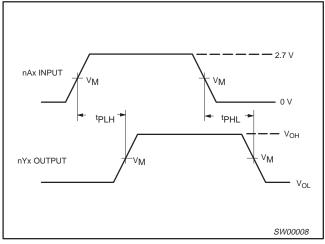
SYMBOL	PARAMETER	WAVEFORM	V _{CC}	= 3.3 V ±0	.3 V	V _{CC} = 2.7 V	UNIT
			MIN	TYP ¹	MAX	MAX	
t _{PLH} t _{PHL}	Propagation delay nAx to nYx	1	0.5 0.5	1.8 1.7	3.2 3.2	4.0 4.0	ns
t _{PZH} t _{PZL}	Output enable time to HIGH and LOW level	2	1.0 1.0	2.3 2.1	4.0 4.0	5.0 5.3	ns
t _{PHZ} t _{PLZ}	Output disable time from HIGH and LOW Level	2	1.0 1.0	3.2 2.9	4.5 4.0	5.0 4.4	ns

NOTE:

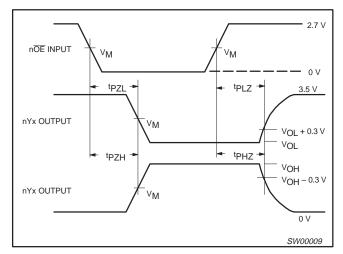
1. All typical values are at V_{CC} = 3.3 V and T_{amb} = 25 °C.

AC WAVEFORMS

 V_{M} = 1.5 V; V_{IN} = GND to 3.0 V.



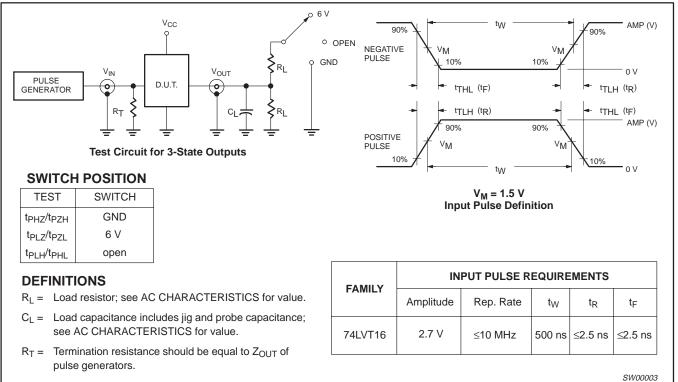


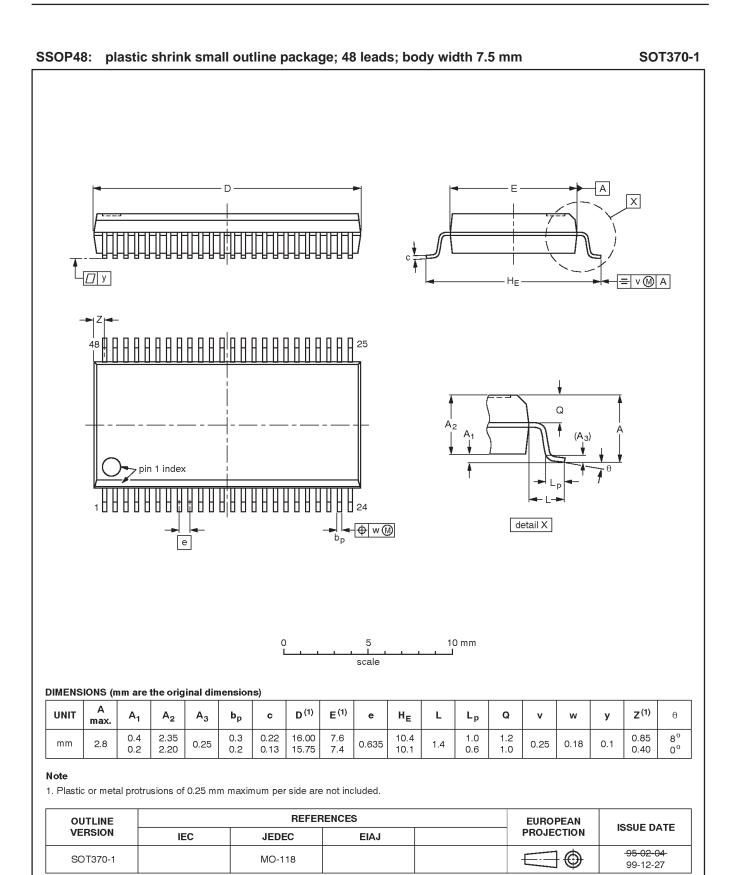


Waveform 2. 3-State Output Enable and Disable Times

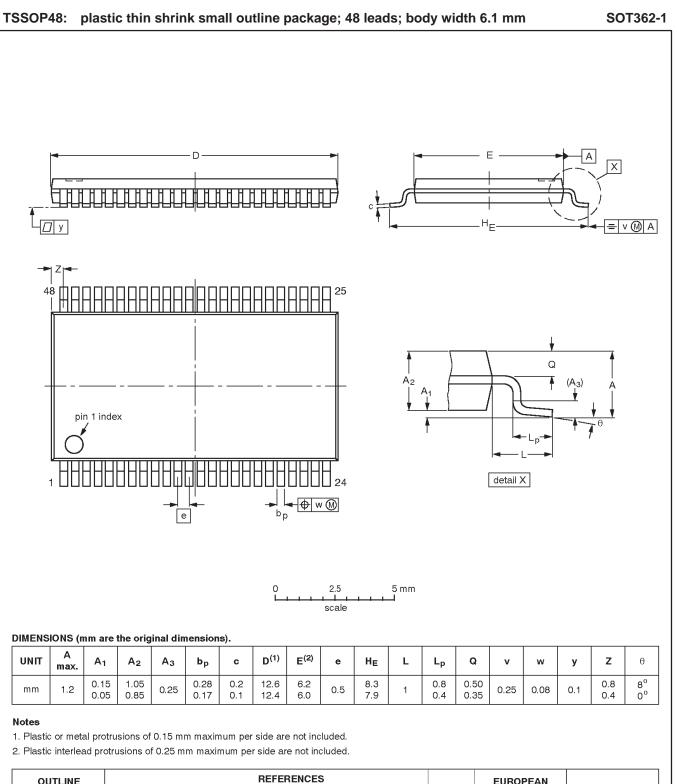
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TEST CIRCUIT AND WAVEFORMS





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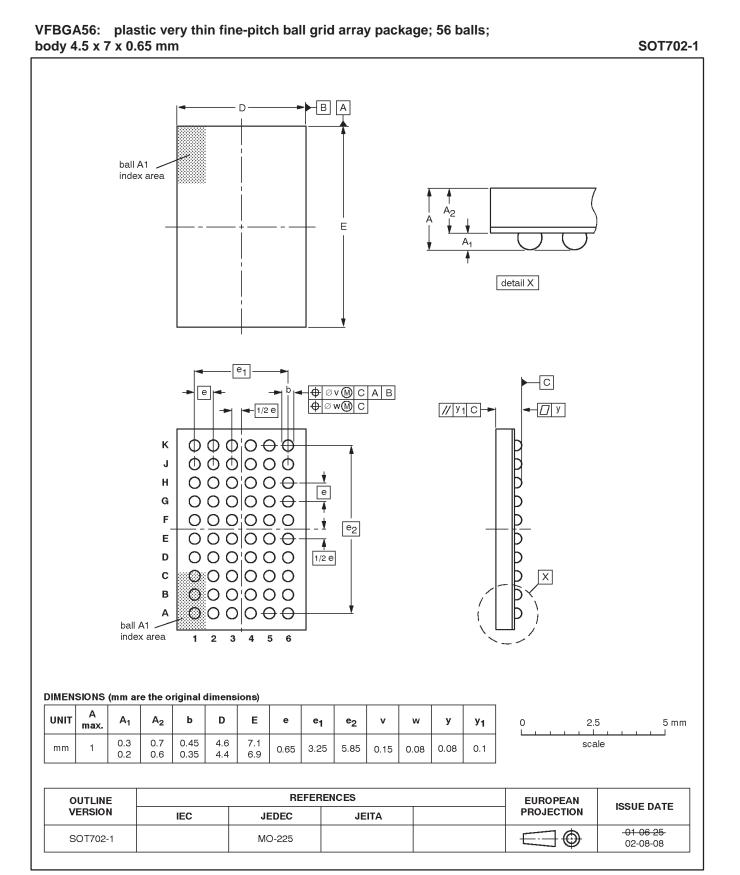
Product data

OUTLINE REFERENCES					EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT362-1		MO-153				- 95-02-10 99-12-27
-			•		•	

Product data

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3.3 V LVT 16-bit buffer/driver (3-State)



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REVISION HISTORY

Rev	Date	Description
_4	20021031	Product data (9397 750 09136); supersedes 74LVT16244B_3 of 1998 Oct 07 (9397 750 04706).
		Engineering Change Notice 853–1778 27401 (date: 20011203).
		Modifications:
		 Add VFBGA56 (EV) package option.

Data sheet status

Level	Data sheet status ^[1]	Product status ^{[2] [3]}	Definitions
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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